

Search Notes

Application/Control No.

10/797,381

Examiner

James D. Stein

Applicant(s)/Patent under
Reexamination

KROPP, JORG-REINHARDT

Art Unit

2874

SEARCHED

Class	Subclass	Date	Examiner
385	15,27,31,3 9,33,49	3/20/2006	JDS

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPGPUB interference search -- see attached EAST search hist		3/20/2006	JDS

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
See attached EAST search history	3/20/2006	JDS
IEEE and INSPEC: bidirectional coupler, lens, detector, waveguide	3/20/2006	JDS
USPGPUB interference search -- see attached EAST search history	3/20/2006	JDS